



Sample &

Buy







CSD19536KCS

SLPS485B - JANUARY 2014 - REVISED OCTOBER 2014

CSD19536KCS 100 V N-Channel NexFET™ Power MOSFET

1 Features

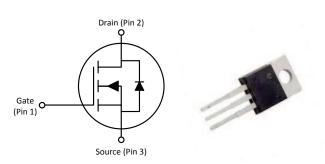
- Ultra-Low Q_q and Q_{qd}
- Low Thermal Resistance
- Avalanche Rated
- Pb-Free Terminal Plating
- RoHS Compliant
- Halogen Free
- TO-220 Plastic Package

2 Applications

- Secondary Side Synchronous Rectifier
- Motor Control

3 Description

This 100 V, 2.3 m Ω , TO-220 NexFETTM power MOSFET is designed to minimize losses in power conversion applications.



Product Summary $T_A = 25^{\circ}C$ TYPICAL VALUE UNIT Drain-to-Source Voltage V V_{DS} 100 Gate Charge Total (10 V) 118 nC Qg Gate Charge Gate to Drain 17 nC Q_{gd} $V_{GS} = 6 V$ 2.5 mΩ R_{DS(on)} Drain-to-Source On-Resistance V_{GS} = 10 V 2.3 mΩ V_{GS(th)} Threshold Voltage 2.5 V

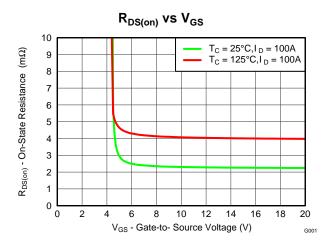
Ordering Information

	•			
Device	Package	Media	Qty	Ship
CSD19536KCS	TO-220 Plastic Package	Tube	50	Tube

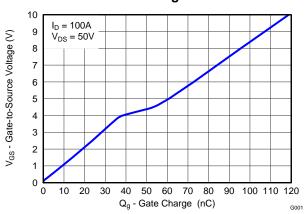
Absolute Maximum Ratings

T _A = 2	5°C	VALUE	UNIT	
V_{DS}	Drain-to-Source Voltage	100	V	
V_{GS}	Gate-to-Source Voltage	±20	V	
	Continuous Drain Current (Package limited)	150		
I _D	Continuous Drain Current (Silicon limited), $T_C = 25^{\circ}C$	259	А	
	Continuous Drain Current (Silicon limited), $T_C = 100^{\circ}C$	183	1	
I _{DM}	Pulsed Drain Current ⁽¹⁾	400	А	
PD	Power Dissipation	375	W	
T _J , T _{stg}	Operating Junction and Storage Temperature Range	-55 to 175	°C	
E _{AS}	Avalanche Energy, single pulse I_{D} = 127 A, L = 0.1 mH, R_{G} = 25 Ω	806	mJ	

(1) Max $R_{\theta JC} = 0.4$ °C/W, pulse duration ≤100 µs, duty cycle ≤1%



Gate Charge



TEXAS INSTRUMENTS

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Table of Contents

 1
 Features
 1

 2
 Applications
 1

 3
 Description
 1

 4
 Revision History
 2

 5
 Specifications
 3

 5.1
 Electrical Characteristics
 3

 5.2
 Thermal Information
 3

	5.3	Typical MOSFET Characteristics	4
6	Dev	ice and Documentation Support	7
	6.1	Trademarks	7
	6.2	Electrostatic Discharge Caution	7
	6.3	Glossary	7
7	Info	hanical, Packaging, and Orderable rmation KCS Package Dimensions	

4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision A (April 2014) to Revision B F Updated Pulsed Drain Current conditions Updated the SOA in Figure 10			
•			
Changes from Original (January 2014) to Revision A	Page		

•	Increased pulsed current rating to 400 A	1
•	Updated SOA curve	6

5 Specifications

5.1 Electrical Characteristics

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$

	PARAMETER	TEST CONDITIONS	MIN TYP	MAX	UNIT
STATIC	CHARACTERISTICS		·		
BV _{DSS}	Drain-to-Source Voltage	$V_{GS} = 0 V, I_D = 250 \mu A$	100		V
I _{DSS}	Drain-to-Source Leakage Current	$V_{GS} = 0 V, V_{DS} = 80 V$		1	μA
I _{GSS}	Gate-to-Source Leakage Current	$V_{DS} = 0 V, V_{GS} = 20 V$		100	nA
V _{GS(th)}	Gate-to-Source Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	2.1 2.5	3.2	V
D	Drain-to-Source On-Resistance	$V_{GS} = 6 V, I_{D} = 100 A$	2.5	3.2	mΩ
R _{DS(on)}	Drain-to-Source On-Resistance	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 100 \text{ A}$	2.3	2.7	mΩ
g _{fs}	Transconductance	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 100 \text{ A}$	307		S
DYNAMI	C CHARACTERISTICS				
C _{iss}	Input Capacitance		9250	12000	pF
C _{oss}	Output Capacitance	V _{GS} = 0 V, V _{DS} = 50 V, <i>f</i> = 1 MHz	1820	2370	pF
C _{rss}	Reverse Transfer Capacitance		47	61	pF
R_{G}	Series Gate Resistance		1.4	2.8	Ω
Qg	Gate Charge Total (10 V)		118	153	nC
Q _{gd}	Gate Charge Gate to Drain		17		nC
Q _{gs}	Gate Charge Gate to Source	— V _{DS} = 50 V, I _D = 100 A	37		nC
Q _{g(th)}	Gate Charge at V _{th}		24		nC
Q _{oss}	Output Charge	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}$	335		nC
t _{d(on)}	Turn On Delay Time		14		ns
t _r	Rise Time	V _{DS} = 50 V, V _{GS} = 10 V,	8		ns
t _{d(off)}	Turn Off Delay Time	$I_{DS} = 100 \text{ A}, \text{ R}_{G} = 0 \Omega$	38		ns
t _f	Fall Time		5		ns
DIODE C	HARACTERISTICS		·		
V_{SD}	Diode Forward Voltage	I _{SD} = 100 A, V _{GS} = 0 V	0.9	1.1	V
Q _{rr}	Reverse Recovery Charge	V _{DS} = 50 V, I _F = 100 A,	548		nC
t _{rr}	Reverse Recovery Time	di/dt = 300 A/µs	110		ns

5.2 Thermal Information

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$

	THERMAL METRIC	MIN	TYP	MAX	UNIT
$R_{ extsf{ heta}JC}$	Junction-to-Case Thermal Resistance			0.4	°C/W
R_{\thetaJA}	Junction-to-Ambient Thermal Resistance			62	°C/W

CSD19536KCS

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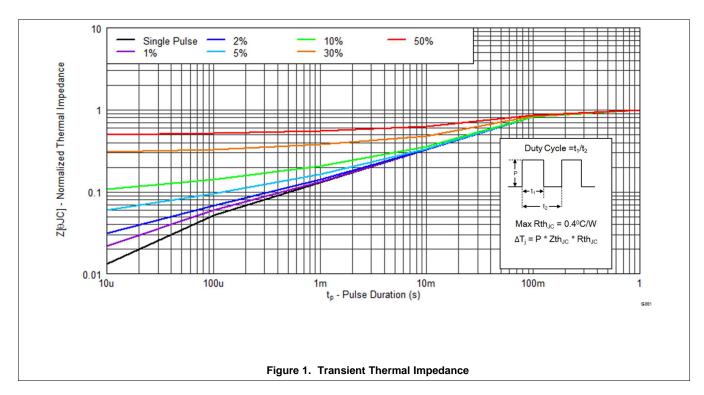
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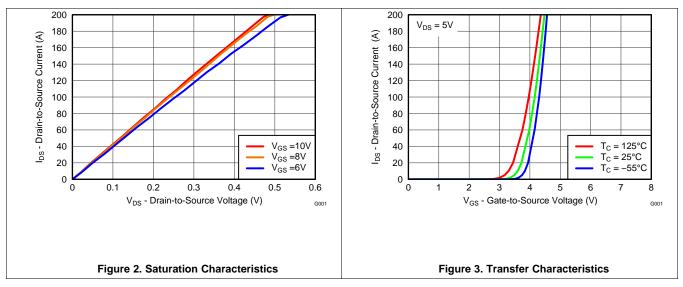
NSTRUMENTS

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5.3 Typical MOSFET Characteristics

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$



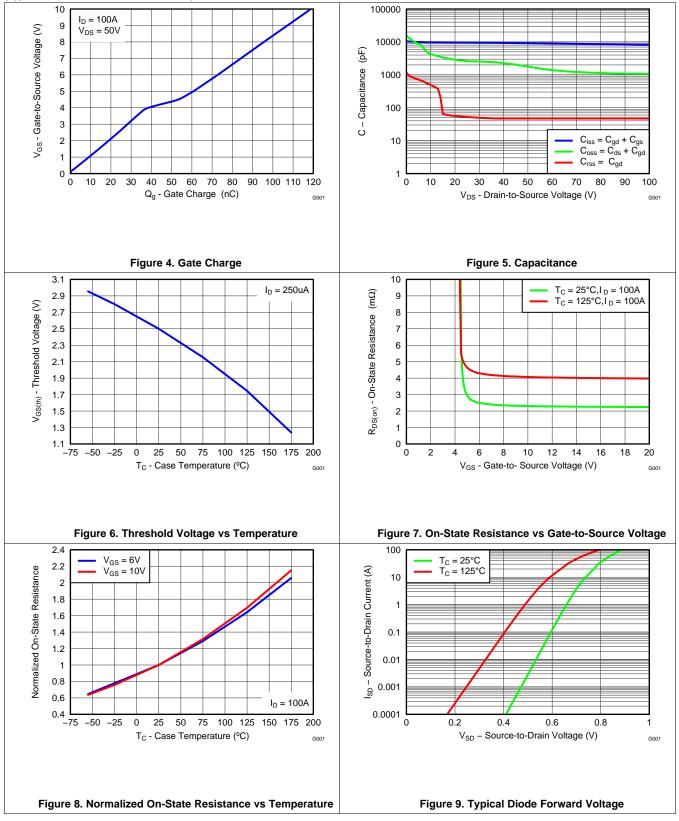


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Typical MOSFET Characteristics (continued)

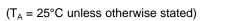
 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$

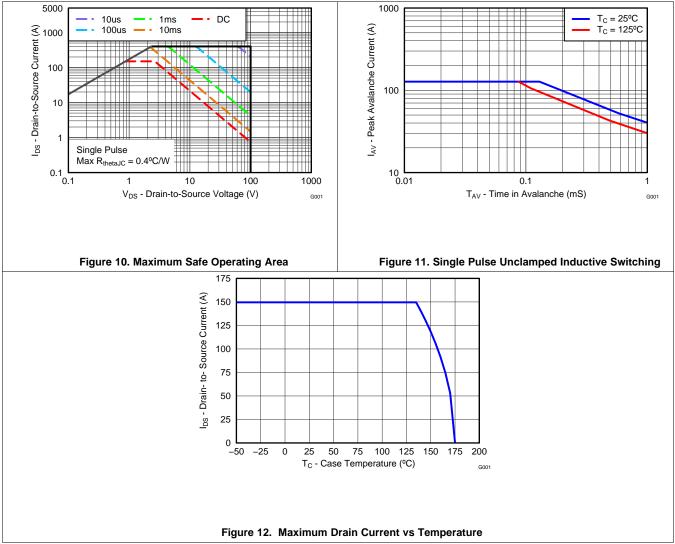




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Typical MOSFET Characteristics (continued)







6 Device and Documentation Support

6.1 Trademarks

NexFET is a trademark of Texas Instruments.

6.2 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

6.3 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

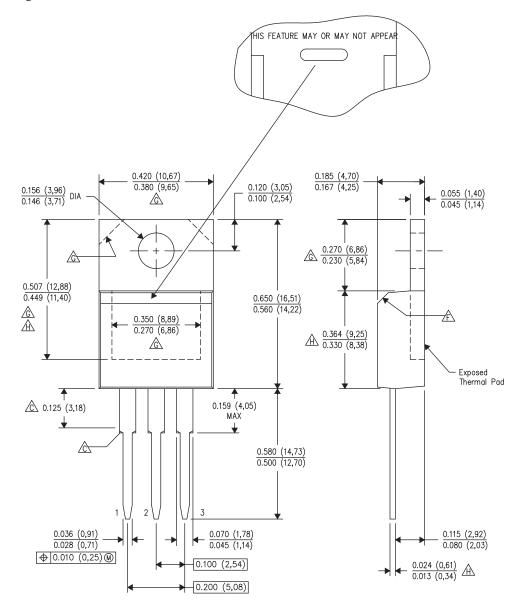


7 Mechanical, Packaging, and Orderable Information

The following pages include mechanical packaging and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



7.1 KCS Package Dimensions



NOTES: А. В. All linear dimensions are in inches (millimeters).

- This drawing is subject to change without notice.
- Lead dimensions are not controlled within this area. Chamfer may or may not appear
 D. All lead dimensions apply before solder dip.
 E. The center lead is in electrical contact with the mounting tab.
- All lead dimensions apply before solder dip. The center lead is in electrical contact with the mounting tab.
- \bigtriangleup The chamfer is optional.
- Thermal pad contour optional within these dimensions.
- 🟦 Falls within JEDEC TO-220 variation AB, except minimum lead thickness, minimum exposed pad length, and maximum body length.

Pin Configuration								
Position	Designation							
Pin 1	Gate							
Pin 2 / Tab	Drain							
Pin 3	Source							

Din Configuration



6-Feb-2020

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package	Pins	Package	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
CSD19536KCS	ACTIVE	TO-220	KCS	3	50	Pb-Free (RoHS)	SN	N / A for Pkg Type	-55 to 175	CSD19536KCS	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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